Application/Control No. Applicant(s)/Patent Under Reexamination 10/666,860 TSUKAMOTO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Dah-Wei D. Yuan 1745 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2004/0055146 03-2004 Tsukamoto et al. Α 029/623.1 В US-US-С US-D US-Е US-F US-G US-Н US-US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Country Code-Number-Kind Code MM-YYYY Name Classification Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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